

SLOVENSKI STANDARD
SIST ES 203 119-7 V1.3.1:2022
01-september-2022

**Metode za preskušanje in specificiranje (MTS) - Jezik za opis preskusa (TDL) - 7.
del: Razširjene preskusne konfiguracije**

Methods for Testing and Specification (MTS) - The Test Description Language (TDL) -
Part 7: Extended Test Configurations

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[SIST ES 203 119-7 V1.3.1:2022](#)

Ta slovenski standard je istoveten z: [ETSI ES 203 119-7 V1.3.1 \(2022-05\)](https://standards.iteh.ai/catalog/standards/ETSI%20ES%20203%20119-7%20V1.3.1%20(2022-05)%200d808da6b820/sist-es-203-119-7-v1-3-1-2022)

ICS:

35.060

Jeziki, ki se uporabljajo v
informacijski tehniki in
tehnologiji

Languages used in
information technology

SIST ES 203 119-7 V1.3.1:2022

en

ETSI ES 203 119-7 v1.3.1 (2022-05)



Methods for Testing and Specification (MTS); The Test Description Language (TDL); Part 7: Extended Test Configurations

[SIST ES 203 119-7 V1.3.1:2022](#)

<https://standards.iteh.ai/catalog/standards/sist/61b5ca9a-f6d7-4d17-bad7-0d808da6b820/sist-es-203-119-7-v1-3-1-2022>

Reference
RES/MTS--TDL1197v131

Keywords
language, MBT, methodology, testing

ETSI

650 Route des Lucioles
F-06921 Sophia Antipolis Cedex - FRANCE

Tel.: +33 4 92 94 42 00 Fax: +33 4 93 65 47 16

Siret N° 348 623 562 00017 - APE 7112B
Association à but non lucratif enregistrée à la
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Foreword

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This ETSI Standard (ES) has been produced by ETSI Technical Committee Methods for Testing and Specification (MTS). <https://standards.iteh.ai/catalog/standards/sist/61b5ca9a-f6d7-4d17-bad7-048084c6b820/sist-es-203-119-7-v1.3.1-2022>

The present document is part 7 of a multi-part deliverable. Full details of the entire series can be found in part 1 [1].

Modal verbs terminology

In the present document "shall", "shall not", "should", "should not", "may", "need not", "will", "will not", "can" and "cannot" are to be interpreted as described in clause 3.2 of the [ETSI Drafting Rules](#) (Verbal forms for the expression of provisions).

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Introduction

This extension package to TDL introduces additional features for the specification of extended test configurations by reusing existing test configurations. Existing test configurations can be instantiated within an extended test configuration. By means of test configuration operations, the test configuration instances can be modified within an extended test configuration, without affecting the original test configuration specification that is instantiated.

The present document describes the relevant abstract syntax (meta-model) extensions as well as the corresponding concrete syntactical notation.

1 Scope

The present document defines extensions to the Test Description Language (TDL) to support the re-use of test configurations.

NOTE: OMG®, UML®, OCL™ and UTP™ are the trademarks of OMG (Object Management Group). This information is given for the convenience of users of the present document and does not constitute an endorsement by ETSI of the products named.

2 References

2.1 Normative references

References are either specific (identified by date of publication and/or edition number or version number) or non-specific. For specific references, only the cited version applies. For non-specific references, the latest version of the referenced document (including any amendments) applies.

Referenced documents which are not found to be publicly available in the expected location might be found at <https://docbox.etsi.org/Reference/>.

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The following referenced documents are necessary for the application of the present document.

- [1] ETSI ES 203 119-1 (V1.6.1): "Methods for Testing and Specification (MTS); The Test Description Language (TDL); Part 1: Abstract Syntax and Associated Semantics".
- [2] ETSI ES 203 119-2 (V1.5.1): "Methods for Testing and Specification (MTS); The Test Description Language (TDL); Part 2: Graphical Syntax".
<https://standards.itek.ai/catalog/standards/sis/61b5ca9a-f6d7-4d17-ba17-21-2022>
- [3] ETSI ES 203 119-3 (V1.5.1): "Methods for Testing and Specification (MTS); The Test Description Language (TDL); Part 3: Exchange Format".
<https://standards.itek.ai/catalog/standards/sis/61b5ca9a-f6d7-4d17-ba17-21-2022>
- [4] ETSI ES 203 119-8 (V1.1.1): "Methods for Testing and Specification (MTS); The Test Description Language (TDL); Part 8: Textual Syntax".

2.2 Informative references

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The following referenced documents are not necessary for the application of the present document but they assist the user with regard to a particular subject area.

Not applicable.

3 Definition of terms, symbols and abbreviations

3.1 Terms

For the purposes of the present document, the terms given in ETSI ES 203 119-1 [1], ETSI ES 203 119-2 [2], ETSI ES 203 119-3 [3], ETSI ES 203 119-8 [4] and the following apply:

component reference: reference to a unique component instance in an extended test configuration

extended gate reference: extension to gate reference that makes it possible to specify gate references from different component instances in a unique manner within an extended test configuration

extended test configuration: specification of a test configuration which includes a set test configuration instances and test configuration operations, as well as additional component instances and connections

flattened test configuration: test configuration resulting from the transformation of an extended test configuration into a test configuration that includes all the component instances and connections from the instantiated test configurations after applying the test configuration operations, as well as additional component instances and connections defined within the extended test configuration

test configuration instance: instantiation of an existing test configuration

test configuration operation: operation on a component instance in an extended test configuration

3.2 Symbols

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3.3 Abbreviations

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For the purposes of the present document, the following abbreviations apply:

OCL™	Object Constraint Language
SUT	System Under Test
TDL	Test Description Language

4 Basic Principles

4.1 Extended Test Configurations

Re-use of test configurations with the capability to modify a test configuration as part of the re-use is an essential feature for managing larger test specifications in TDL. This extension for the specification of extended test configurations in TDL provides the necessary capabilities for instantiating existing test configuration within an extended test configuration, as well as modifying the instantiated test configurations by means of test configuration operations. Extended test configurations are intended for higher-level specification of reusable test configurations. An extended test configuration shall be transformed into a "*flattened*" test configuration in order to be used in a test description. The flattened test configuration shall contain all the component instances and connections from the instantiated test configurations after applying the test configuration operations, as well as additional component instances and connections defined within the extended test configuration.

4.2 Document Structure

The present document defines the composite test configuration extensions for TDL comprising:

- Meta-model extensions describing additional concepts required for the specification of extended test configurations (clause 5).
- Concrete syntax extension describing corresponding shapes for the representation of the additional concepts (clause 6).
- An informative annex with examples (annex A).

4.3 Notational Conventions

The present document inherits the notational conventions defined in ETSI ES 203 119-1 [1] and ETSI ES 203 119-2 [2].

The abstract syntax specification and the classifier descriptions follow the notational conventions defined in clause 4.5 of Abstract Syntax and Associated Semantics [1]. The concrete graphical syntax notation specification follows the notational conventions described in clause 4.5 of the Graphical Syntax [2]. The concrete textual notation follows the notational conventions described in clause 4.3 of the Textual Syntax [4].

4.4 Element Operations

The formalized constraints for the present document rely on operations provided by the standard library of OCL and in ETSI ES 203 119-1 [1].

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4.5 Conformance

For an implementation claiming to conform to this extension of the TDL meta-model, all concepts specified in the present document and in ETSI ES 203 119-1 [1], as well as the concrete syntax representation specified in the present document shall be implemented consistently with the requirements given in the present document and in ETSI ES 203 119-1 [1]. The electronic attachment from annex A in ETSI ES 203 119-1 [1] may serve as a starting point for a TDL meta-model implementation conforming to the present document and the overall abstract syntax of TDL [1].

5 Meta-Model Extensions

5.1 Overview

The extended test configuration concepts are defined within a single package in the TDL meta-model. The additional concepts are "self-contained" in that a specification that relies on them shall be transformed into a test configuration that does not make any use of the additional concepts before using the test configuration in a test description.

5.2 ExtendedTestConfiguration

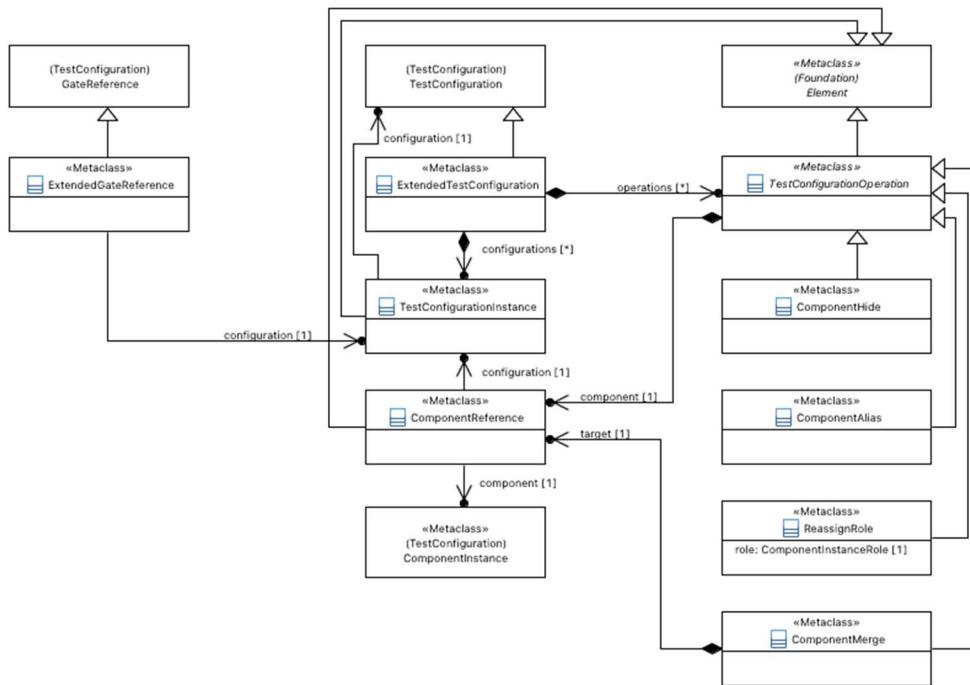


Figure 5.2.1: Extended test configuration specification concepts

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Semantics

An 'ExtendedTestConfiguration' is a refinement of 'TestConfiguration' that contains the 'TestConfigurationInstance's and 'TestConfigurationOperation's enabling the reuse of existing 'TestConfiguration's. The 'TestConfigurationOperation's shall be applied in the specified order.

Generalization

- TestConfiguration.

Properties

- configurations: TestConfigurationInstance [0..*]
The instantiated 'TestConfiguration's.
- operations: TestConfigurationsOperation [0..*]
The 'TestConfigurationOperation's for the refinement of the instantiated 'TestConfiguration's.

Constraints

- There are no constraints specified.

5.3 TestConfigurationInstance

Semantics

A 'TestConfigurationInstance' represents an instantiation of an existing 'TestConfiguration'. All 'ComponentInstance's and 'Connection's of the instantiated 'TestConfiguration' shall be replicated.